

30V N-Channel Trench MOSFET(Preliminary)

General Description

- Trench Power technology
- Low R_{DS(ON)}
- Low Gate Charge
- Optimized for fast-switching applications

Applications

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

Product Summary

$$\begin{split} V_{DS} & 30V \\ I_{D} & (at \ V_{GS} = 10V) & 110A \\ R_{DS(ON)} & (at \ V_{GS} = 10V) & < 3.4 \text{m}\Omega \end{split}$$

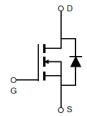
 $R_{DS(ON)}$ (at $V_{GS} = 4.5V$) < $4.5m\Omega$

100% UIS Tested









Part Number	Package Type	Form	Marking
TTP110N03GT	TO-220	Tube	110N03GT

Absolute Maximum Ratings (T_A =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	30	V
Gate-Source Voltage		V _{GS}	±20	V
Ocationary Ducie Ocament B	T _C =25°C		105	Δ.
Continuous Drain Current B	T _C =100°C	I _D	76	А
Pulsed Drain Current ^A		I _{DM}	330	Α
Avalanche Current A		I _{AS}	27.6	Α
Single Pulse Avalanche Energy L =0.3mH A		E _{AS}	114.3	mJ
Power Dissipation ^C	T _C =25°C	P _D	80	W
	T _C =100°C		32	W
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	°C

Thermal Characteristics

Parameter		Symbol	Maximum	Units	
Maximum Junction-to-Case	Steady-State	$R_{\Theta JC}$	1.32	00444	
Maximum Junction-to-Ambient	Steady-State	R _{OJA}	100	°C/W	



		Conditions		Value			
Symbol	Parameter			Min	Тур	Max	Units
STATIC P	ARAMETERS	1					<u>.</u>
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA,V _{GS} =0V		30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V	T _J =25°C T _J =100°C			1 25	μA
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	1			±100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		1	1.7	2.4	V
		V _{GS} =10V, I _D =20A			2.6	3.4	mΩ
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 4.5V, I_{D} = 20A$			3.5	4.5	mΩ
g _{FS}	Forward Transconductance	V _{DS} =10V, I _D =20A			16.8		S
V _{SD}	Diode Forward Voltage	I _S =30A, V _{GS} =0V				1	V
I _S	Maximum Body-Diode Continuous Curre	m Body-Diode Continuous Current ^B				105	Α
DYNAMIC	PARAMETERS					•	
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f =1MH _Z			3842		pF
C _{oss}	Output Capacitance				1276		
C _{rss}	Reverse Transfer Capacitance				814		
SWITCHII	NG PARAMETERS				•		
Q _g (10V)	Total Gate Charge	V _{GS} =10V,V _{DS} =15V, I _D =50A			77		
Q_{gs}	Gate Source Charge				9		nC
Q_{gd}	Gate Drain Charge				17		
t _{D(on)}	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 15V, I_{D} = 50A,$ $R_{G} = 3\Omega$			13		
t _r	Turn-On Rise Time				12		ns
T _{D(off)}	Turn-Off Delay Time				43		
t _f	Turn-Off Fall Time				19		
t _{rr}	Body Diode Reverse Recovery Time	1 004 457 4000			21		ns
Q _{rr}	Body Diode Reverse Recovery Charge				19		nC

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation P_D is based on $T_{J(MAX)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

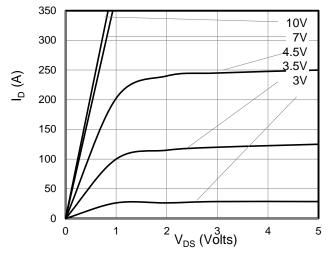


Figure 1: On-Region Characteristics

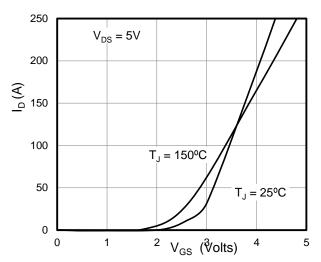


Figure 2: Transfer Characteristics

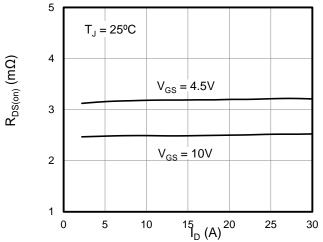


Figure 3: On-Resistance vs. Drain Current

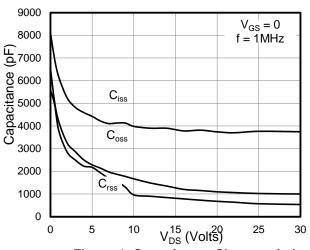


Figure 4: Capacitance Characteristics

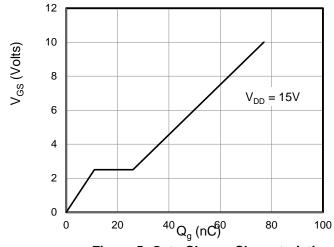


Figure 5: Gate Charge Characteristics

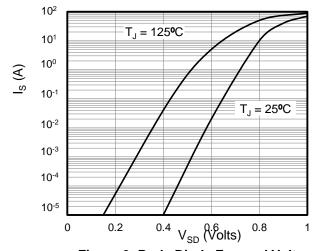
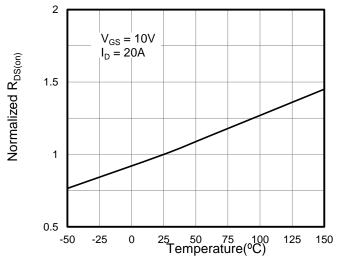


Figure 6: Body Diode Forward Voltage

 $Z_{\theta, JC}$ Normalized Transient Thermal Resistance

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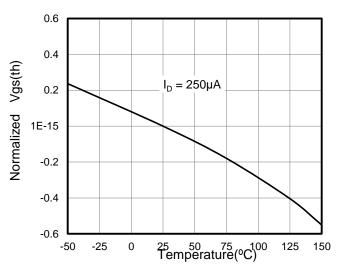
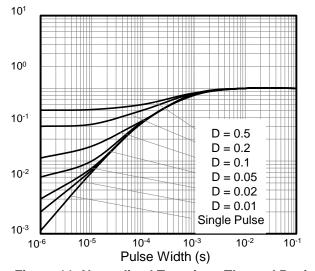


Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature



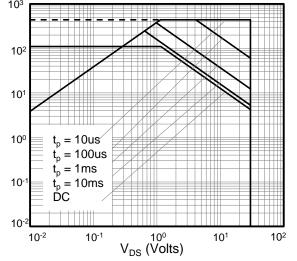


Figure 11: Normalized Transient Thermal Resistance

Figure 12: Safe Operating Area

I_D (Amps)

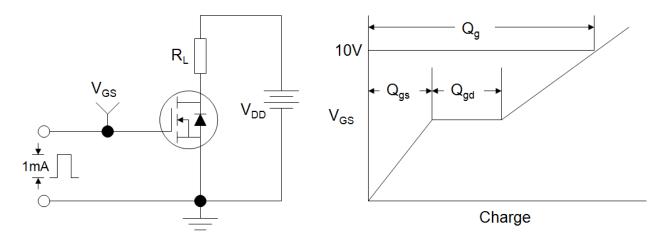


Figure A: Gate Charge Test Circuit and Waveforms

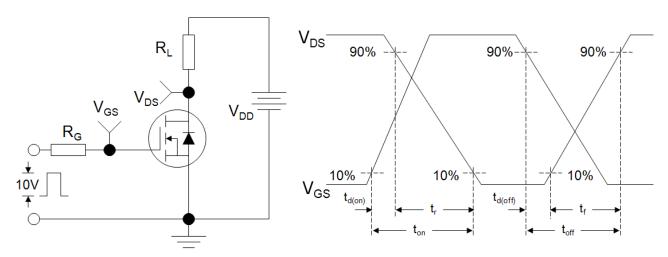


Figure B: Resistive Switching Test Circuit and Waveforms

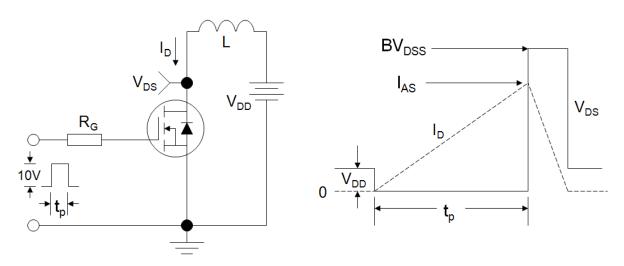
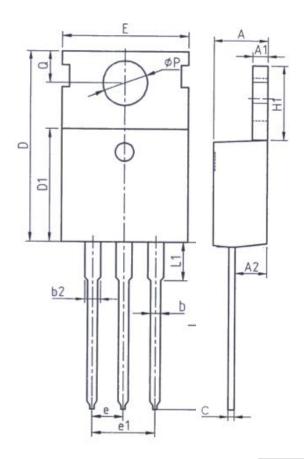
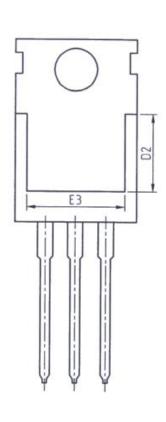


Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms



TO-220





Unit: mm			
Symbol	Min.	Max.	
Α	4. 37	4. 77	
A1	1. 25	1. 45	
A2	2. 20	2. 60	
ь	0. 70	0. 95	
b2	1. 17	1. 47	
С	0. 40	0. 65	
D	15. 10	16. 10	
D1	8. 80	9. 40	
D2	5. 50	_	

Unit: mm			
Symbol	Min.	Max.	
E	9. 70	10. 30	
E3	7. 00	ı	
е	2. 54BSC		
e1	5. 08BSC		
H1	6. 25	6. 85	
L	12. 75	13.80	
L1	-	3. 40	
Р	3. 40	3. 80	
Q	2. 60	3. 00	



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